

Form PTO-1440 Rev. 7-3-04		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO.	SERIAL NO.
				APPLICANT	<i>Johns et al./Tiwari et al.</i>
				FILING DATE	GROUP

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
MD	AA	65739999	6/2003	Yangs..	356	632	
MD	AB	6349594	2/2002	Yabe	73	150	
AC		5484701	1/1996	Norton et al.	250	372	
MD	AD	5798837	8/1998	Arpner et al	356	369	
	AE	4105338	8/1978	Iwahashi	356	118	
	AF	5181080	1/1993	Fanton et al	356	369	
	AG	4826321	5/1989	Coates et al.	356	351	
	AH	5910842	6/1996	Piwonka - Gole et al	356	369	
↓	AI	5517312	5/1996	Fingrov	356	386	
	AJ	62785198	8/2001	Rosenbaum et al	356	369	
MD	AK	4899055	2/1990	Adam	250	372	

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES	NO
	AL							
	AM							

OTHER PRIOR ART (Including Author, Title, Date, Pertinent Pages, Etc.)

MD	AR	OPSAL et al Pub No US 2002/0176081 A1, Nov. 28, 2002, Serial No. 10/138,984
	AS	

EXAMINER	/Marissa Detschel/	DATE CONSIDERED	05/24/2006
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EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

ATTY. DOCKET NO.

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LIST OF PRIOR ART CITED BY APPLICANT
(Use several sheets if necessary)

APPLICANT	<i>Joh & Tward</i>
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U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
MD	AA	5798837	8/1998	Aspnes et al.	356	369	
	AB	5793480	8/1998	Lacey et al.	356	77	
	AC	5900939	5/1999	Aspnes et al	356	369	
	AD	5595916	11/1997	Fujimura et al	432	8	
	AE	6605482	8/2003	Celii et al.	438	16	
▼	AF	6278509	8/2001	Johnson et al	385	17	
MD	AG	5871805	2/1999	Lemelson	427	8	
	AH						
	AI						
	AJ						
	AK						

FOREIGN PATENT DOCUMENTS

	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION
						YES
AL						
AN						

OTHER PRIOR ART (including Author, Title, Date, Pertinent Pages, Etc.)

MD	AR	DATA Analysis for Spectroscopic Ellipsometry, Thin Solid Films 234 (1993) by Jellison Jr.
	AS	

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		05/24/2006

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